W eak ferrom agnetism of $La_{1:99}Sr_{0:01}CuO_4$ thin Im s: evidence for rem oval of corrugation in CuO_2 plane by epitaxial strain

I. T sukada

Central Research Institute of Electric Power Industry, 2-11-1 Iwado-kita, Komaeshi, Tokyo 201-8511, JAPAN (Dated: March 22, 2024)

The weak ferror agnetism of $La_{1:99}Sr_{0:01}CuO_4$ epitaxial thin lms is investigated using magnetoresistance measurement. While a steplike negative magnetoresistance associated with the weak ferror agnetic transition is clearly observed in the lms grown on YAD₃ (001), it is notably suppressed in the lms grown on SrT iO₃ (100) and (LaAD₃)_{0:3} (SrAl_{0:5}Ta_{0:5}O₃)_{0:7} (100), and almost disappears in lms grown on LaSrAD₄ (001). The strong suppression of the steplike magnetoresistance provides evidence that the CuO₂ planes are much less corrugated in thin lms grown on tetragonal substrates, particularly on LaSrAD₄ (001), than in bulk crystals.

PACS num bers: 74.25 Fy,74.72 D n,75.50 Ee,74.78 B z

Epitaxial growth of $La_2 \times Sr_xCuO_4$ (LSCO) and $La_2 \times Ba_x CuO_4$ (LBCO) superconductors has been gathering much attention since a remarkable increase in T_{c} was reported for $\ln s$ grown on LaSrA D_4 (001).^{1,2,3} In these studies, in-plane com pressive and out-of-plane tensile strains applied to the lattice were found to be favorable for the increase of T_c. A s is widely known, bulk crystals of LSCO have two phases: high-tem perature tetragonal (HTT, I4=mmm) and low-tem perature orthorhombic (LTO, Bm ab) phases. In the LTO phase, a staggered rotation of the CuO₆ octahedra gives rise to the characteristic corrugation in the CuO₂ plane. Considering that superconductivity occurs in this LT 0 -phase stable region for bulk unstrained crystals, we expect that the epitaxial strain a ects the superconducting properties through a modi cation in the corrugated structure. However, it seems di cult to directly investigate a such m icroscopic structure in thin- Im samples; we usually apply a neutron di raction m ethod to a bulk crystal for such purpose, but it may not apply to a thin- lm sam ple because of its too small volume. Thus far, there has been no report on the true role of epitaxial strain of LSCO and LBCO thin lm s.

An indirect but prospective approach to the corrugation in the CuO₂ plane is to study an antiferromagnetic sample instead of a superconducting one, because the corrugation is strongly coupled to antiferromagnetism and weak ferrom agnetism of LSCO. In the LTO phase, the corrugated structure of the CuO_2 plane allows D zyaloshinskii-M oriya (DM) interactions to work between the nearest-neighbor spins on Cu^{2+} ions.⁴ The DM interactions consequently induce cooperative spin canting, giving rise to a weak ferrom agnetic (WF) mom ent perpendicular to the CuO₂ plane, which alternately changes its direction along the c axis. Since the coupling of the W F m om ents on adjacent layers is rather weak, one can drive a W F transition by applying magnetic eld along the caxis; above the critical eld, the W F m om ents point in the sam e direction at every CuO₂ plane. This et al. have reported that the out-of-plane resistance shows a steep decrease at the critical eld_{I}^{4}

indicating a strong coupling of electronic transport and m agnetic ordering. Recently, A ndo et al. have discovered that the in-plane m agnetoresistance also exhibits a characteristic steep decrease across the W F transition.⁵ The in-plane m agnetoresistance, therefore, can be a sensitive probe of the weak ferrom agnetism that is strongly coupled with the corrugated structure of the CuO₂ plane. In this paper, we report the in-plane m agnetoresistance for the antiferrom agnetic (AF) $La_{1:99}Sr_{0:01}CuO_4$ thin Im s epitaxially grown on four di erent substrates, and discuss how the corrugation of the CuO₂ plane is modi ed by the epitaxial strain.

La1:99Sr0:01CuO4 thin In swere prepared by pulsedlaser deposition (K rF excimer, = 248 nm). Substrate tem perature was kept at 800 C during the deposition in an atm osphere of 30 m Torr oxygen. This grow th condition is the same as that used for a previous report. Under this grow th condition we can grow superconducting LSCO thin Im s with very low residual resistivity implying few crytallographic imperfections. The laser repetition rate was set at the lowest value (f = 1 H z) to properly apply strain to the Ims. A polycrystalline sintered target of La_{1:99}Sr_{0:01}CuO₄ was prepared by a solid-state reaction method. At this Sr concentration, we expect that the AF long-range order appears at T 200 K in a bulk crystal.⁷ The actual chem ical com position of the grown Im became slightly La-rich (La:Sr:Cu = 2.28:0.01:1.00), but this deviation does not signi cantly a ect the antiferrom agnetism of the sample. We used four substrates: orthorhom bic YA 10 3 (001) has a rectangular surface sym m etry, w hile tetragonalLaSrA 10 4 (001), cubic $(LaA D_3)_{0:3}$ (SrT $a_{0:5}A h_{:5}O_3)_{0:7}$ (100), and cubic SrT iO₃ (100) have a square surface symmetry. Hereafter, these substrates are referred to as YAP (Yttrium Alminum Perovskite), LSAO, LSAT, and STO, respectively. To avoid confusion, we follow the axis notation of the LTO structure of LSCO. Film thickness was set at approximately t = 1800A. A fter patterning the lm s for four-term inalm easurem ents, they were carefully annealed at 600 C in helium to rem ove extra oxygen follow ing the procedure for lightly doped bulk crystals. Since

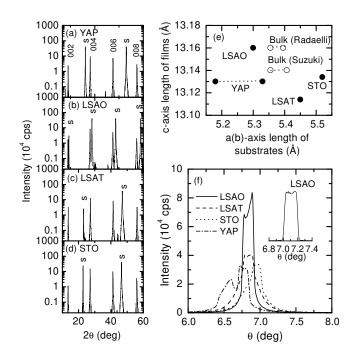


FIG.1: (a)-(d) X -ray di raction of the lm s taken by -2 goniom eter. Re ections from the substrates are indicated by s. (e) Relationship between the lattice parameters of substrates and the c-axis lengths of the lm s. The data for bulk sam ples of $La_2 CuO_4$ are taken from Refs. 9 and 10. (f) The Rocking curve of the 002 re ection. Inset show s that of LSAO substrate.

the extra oxygen can easily induce superconductivity, as discussed by Sato et al.¹ and Bozovic et al.⁸ this postannealing in helium is crucial for the present experiments. The in-plane resistivity wasmeasured under the magnetic

eld up to 10 T by the Physical Properties M easurem ent System (PPM S, Q uantum D esign).

The x-ray di raction show sthat all the $\,$ In s are highly c-axis oriented as shown in Figs. 1 (a)-1 (d). The c-axis length estim ated from all of the observed 001 (l : even) re ections is plotted as a function of the a (b)-axis length of substrates in Fig. 1 (e) with the data of ceram ic sam – ples of La_2CuO_4 9,10 A lthough the c-axis length does not show monotonic behavior at rst glance, this variation is consistent with the results reported by Sato et al. for La_{1:85}Sr_{0:15}CuO_4 $\,$ In s, i.e., a signi cant change in the c-axis length is observed only in the $\,$ In grown on LSAO or LSAT . Their in-plane lattice param eters are very close to those of LSCO, which results a remarkable expansion or com pression of the c-axis length. In contrast, the

In s gown on YAP and STO, where the lattice m is ts are much larger, do not feel the strain fully, and consequently, the c-axis length approaches a certain value that is determ ined only by therm odynam ics. We actually observed that the c-axis lengths of these Im s are alm ost equal.

In order to see m ore detail, we com pared the rocking

curve around the 002 refelection as shown in Fig.1 (f). The 002 re ection is the lowest-index di raction, and considered to be the most sensitive to wide-area crystallographic quality. We see that the peak height of the lm on LSAO is twice as high as that of the others, which indicates the better orientation than the others. The m ore im portant feature is, how ever, a shape of the peak; The peak width is the narrowest for the lm on LSAO. The splitting at the peak top is due to the nite mosaioness of the LSAO substrate (see the inset), and thus, the peak width of each dom ain is considered to be much narrower than the width shown in Fig. 1 (f). A nother im portant feature is that this peak does not have a broad tail, which is only the case of the lm on LSAO. The absence of the tail indicates that the epitaxial strain is applied entirely through the lm. The contrasting behavior is observed in the lm s grown on LSAT and STO, where the broad tail is observed in their rocking curves. The peak structures of these Im s look like a superposition of a narrow intense and a broad less-intense peaks. The presence of the narrow intense peak indicates that a prat of the lm is well strained like the lm on LSAO. However, the accompanying broad peaks suggests that the lattice relaxation occurs in another part of the lm s. In general, when lattice relaxation proceeds according to the Im growth, the Im begins to be divided into do-

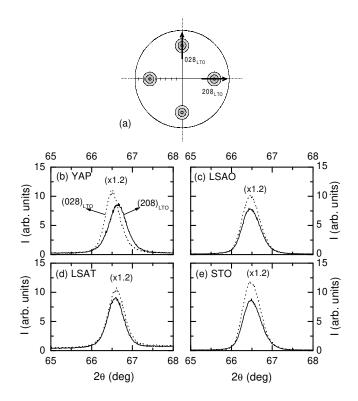


FIG. 2: (a) Schematic of 208 and 028 re ections in the pole-gure con guration. The scan directions of the peaks in (b)-(e) are indicated by arrows. (b)-(e) 208 (solid line) and 028 (dotted line) re ections of the lm s grown on YAP (001), LSAO (001), LSAT (100), and STO (100). The intensity of the 028 re ection is multiplied by 1.2.

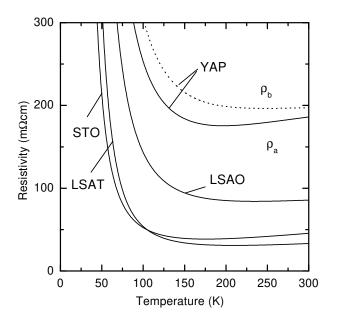


FIG. 3: Temperature dependence of the in-plane resistivity of the lm s. For the lm grown on YAP, the resistivity is anisotropic along two orthogonal directions (solid and dotted lines), while such an anisotropy is absent in the other lm s.

mains with slightly di erent orientation when the lm can no longer hold the strain. Thus, the rocking curves of these lms show that the lms grown on LSAT and STO may consists of lower fully-strained layers and upper less-strained (relaxed) layers. The rocking curve of the lm grown on YAP looks much more complicated. However, if you looks at the each peak, you can see that the peak width is comparable to the others. From this rocking curve, we expect that the lattice relaxation begins alm ost at the initial stage of the lm growth, and thus, cracks also start to grow from the lm-to-substrate interface. As will be shown later, we observe the highest resistivity in the lm grown on YAP, which is consistent with this expectation.

Next, we con med the in-plane crystallographic sym metry. For this purpose, we used a pole- gure goniom eter to scan both the 208 and 028 re ections. Figures 2(b)-2(e) show the single scans of the 208 and 028 re ections. The scan direction is indicated by an arrow in Fig. 2(a). For the lm grown on YAP, the 208 and 028 re ections appear at di erent angles indicating the orthorhom bic symmetry, and the in-plane orientation is determined as YAP [100] k LSCO [100], which may allow us to expect that the corrugation survives in the CuO₂ plane. On the other hand, the two re ections appear at the same angle for the lm s grown on LSAO, LSAT, and STO. However, these results do not im m ediately mean that these Im s are really tetragonal. For exam ple, B i_2 Sr₂C a_{n-1} C u_n O $_{2n+4}$ is orthorhom bic and does not become tetragonal even when grown on STO (100), but it exhibits a twin structure composed of orthorhom bic dom ains.¹¹ Thus, we cannot judge whether the corrugation is actually rem oved from these three Im s as this stage, and therefore, the m agnetoresistance m easurem ent becom es im portant.

The in-plane resistivity of all $\ln s \exp hibit$ an insulating behavior upon approaching T = 0 K, as shown in Fig. 3. In contrast to the resistivity data reported for superconducting sam ples,^{1,2,3} the $\ln s$ grown under the compressive strain (YAP and LSAO) show a higher resistivity than those grown under the tensile strain (LSAT and STO). The \ln grown on YAP is orthorhom bic, as was shown before, and has resistivity anisotropy along the a and b axes; a is always lower than b for this \ln , and the temperature where the resistivity shows a minimum value is also lower for a than for b. Such di erent temperature dependences are qualitatively consistent with those for bulk crystals with x 0.02,¹² which supports our identication of the a- and b-axis directions. The other three $\ln s$ show alm ost no in-plane anisotropy.

A fler characterizing the lm s by x-ray di raction and resistivity m easurements, we measured the in-plane magnetoresistance. Figures 4 (a) and 4 (b) show the magnetoresistance measured at T = 40 K and its rst derivative, respectively, in which we can easily see a marked di erence between the lm grown on YAP and those grown on the others. The lm grown on YAP exhibits a clear step-like magnetoresistance, like bulk crystals do.⁵ A s shown in Fig. 4 (c), R (H)=R (0) at T = 200 K is almost eld-independent up to H = 10 T, while below T = 150 K, R (H)=R (0) show s an apparent decrease above approx-

in ately H = 2 T; a steep decrease begins at H = 2 Tand alm ost ends at H = 6 T. For convenience, we will de ne the W F transition eld as the eld where the rst derivative shows a m inimum. A coording to this de nition, $H_{WF} = 4 T$ is obtained for this lm as indicated by an arrow in Fig. 4 (b). From the magnetoresistance data, we can roughly estim ate the N celtern perature (T_N) for this lm by plotting the temperature dependence of

R (H)=R (0) at several elds (Fig. 5). R (H)=R (0) is alm ost zero at H < H $_{W \ F}$ (1 and 2 T) through the tem – perature range below 300 K, while the deviation to negative values becomes apparent below T = 200 K when the

eld is higher than $H_{W\ F}\,$ (6 and 10 T). As a result, the AF long-range order is considered to set in at approximately T = 200 K. This assignment is consistent with $T_N\,$ reported for bulk crystals.⁷

The other three $\,$ In s grown on tetragonal surfaces show contrasting behavior. The steplike magnetoresistance behavior is strongly suppressed in comparison with the $\,$ In s grown on YAP.AtT = 40 K and H = 10 T, R (H)=R (O) reaches only -1.1% (LSAO), -0.9% (LSAT), and -1.4% (STO), which are far smaller than that observed for the $\,$ Im grown on YAP.N evertheless, one can nd traces of the W F transition in the $\,$ Im s grown on LSAT and STO.Figure 4 (b) shows that the W F transition still occurs at H $_{\rm W \ F}$ 2.5 T for these two $\,$ Im s, even though the critical eld is lower than that for the $\,$ Im on YAP. In these $\,$ Im s, we may expect that $T_{\rm N}$ shifts to lower temperatures. As shown in Fig. 4 (e), the magnetic structure is the structure of the magnetic structure in the magnetic structure is the magnetic structure in the magnetic structure is the magnetic structure in the magnetic structure is a shown in Fig. 4 (e), the magnetic structure is the magnetic structure is the magnetic structure in the magnetic structure is the magnetic structure is the magnetic structure in the magnetic structure is the magnetic structure is the magnetic structure in the magnetic structure is the magnetic structure is the magnetic structure in the magnetic structure is the structure in the magnetic structure is the structure in the magnetic structure is the structure in the structure in the structure is the structure in the structure in the structure is the structure in the structure in the structure is the structure in the structure in the structure is the structure in the structure in the structure is the structure in the structure in the structure is the structu

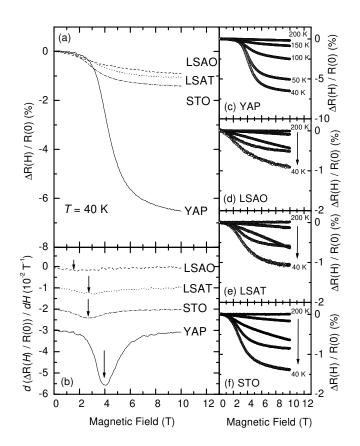


FIG.4: (a) In-plane m agnetoresistance of $La_{1:99} Sr_{0:01} CuO_4$ thin lm sm easured at T = 40 K.The large steplike negative m agnetoresistance associated with the W F transition, which is signi cant in the lm grown on YAP, almost disappears in the lm s grown on LSAO, LSAT, and STO. (b) The rst derivative of the m agnetoresistance shown in (a). (c)-(f) The tem perature variations of the in-plane m agnetoresistance for each lm.

netoresistance of the $\,$ lm on LSAT maintains a convex upward- eld dependence even at T = 100 K and a trace of the steplike behavior appears only below T = 50 K, which suggests that the $T_{\rm N}\,$ of this $\,$ lm is found between 50 and 100 K.

The weak ferror agnetism is more strongly suppressed in the lm grown on LSAO, and the rst derivative of the magnetoresistance become salm ost eld-independent. We can no longer obtain clear H_{WF} from Fig. 4(b). If one carefully analyzes Fig. 4(b), H_{WF} is still discernible around H = 1.5 T. How ever, this value is even low er than the H_{WF} 's of the lm s grown on LSAT and STO, and we conclude that the weak ferror agnetism is most strongly suppressed in the lm grown on LSAO.

One may wonder if the result obtained above is strongly dependent on Im thickness, because the lattice strain applied from substrate may be relaxed by increasing the Im thickness in general, which will result a recovery of step-like magnetoresistance. Since the Im grown on LSAT indicates slight but nite corrugations in the CuO_2 plane as is implied from Fig. 3, LSAT is considered to be the most appropriate substrate to study

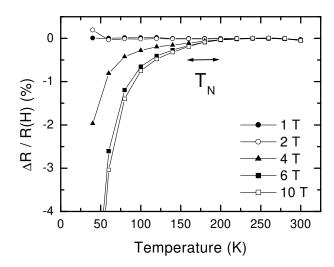


FIG.5: Tem perature dependence of the magnetoresistance for $La_{1:99}Sr_{0:01}CuO_4$ lm s grown on YAP (001) m easured at H = 1, 2, 4, 6, and 10 T.

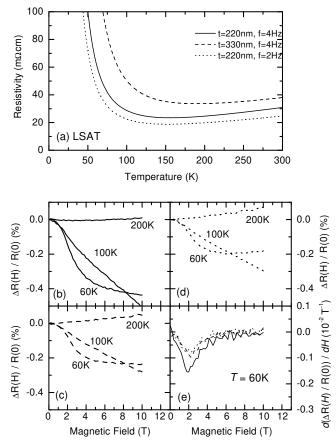


FIG.6: (a) Temperature dependence of the in-plane resisitivty of La_{1:99} Sr_{0:01}CuO₄ thin lm s on LSAT (100) prepared under the conditions di erent from those shown in Figs. 2 and 3. (b) The magnetoresistance of the lm (t = 2200A) prepared at f = 4Hz. (c) The magnetoresistance of the lm (t = 3300A) prepared at f = 4Hz. (d) The magnetoresistance of the lm (t = 2200A) prepared at f = 2Hz. (e) The rst derivative of the magnetoresistance at T = 60K shown in (b)-(d).

the thickness dependence. Figure 6 shows the resistivity and magnetoresistance of the lm s grown on LSAT (100) prepared under the condition di erent from that for the

In shown in Fig. 4: t= 2200A at f= 4 Hz, t= 3300A at f = 4 H z, and t = 2200 A at f = 2 H z. A lthough the m agnitude of the resistivity is not completely identical, its tem perature dependence is sim ilar to one another and that for typical insulating LSCO with x=0.01 as shown in Fig. 6(a).⁵ Figures 6(b) - 6(d) show the magnetoresistance m easured at T = 200, 100, and 60 K. It is easily seen that all the lm s exhibit alm ost the same behavior as that in Fig. 4(e). At T = 200 K, the magnetoresistance is slightly positive and almost featureless. W hen tem perature is decreased down to 100 K, the negative m agnetoresistance becom es apparent. but step-like behavior is still absent. A fter the tem perature is decreased to 60 K, the step-like behavior shows up. W hat we should emphasize is that the overall magnetoresistance behavior is qualitatively the same among F igs. 4 (e), 6(b)-6 (d). The magnitude of magnetoresistance at H = 10 T is less than 0.5 % at T = 60 K, again suggesting the corrugation of the CuO₂ plane rem ains but its tilting is strongly suppressed. The st derivative of the magneto resistance traces alm ost the identical line (Fig. 6(e)), which suggests the weak-ferrom agnetic transition occurs at the same eld regardless of the lm thickness. As a result, we may safely conclude that the general behavior of the magnetoresistance shown in Fig. 4 is not so strongly dependent on the Im thickness and/or the growth condition.

W e are now ready to discuss the m icroscopic structure of the CuO₂ plane. A s has been reported for La₂CuO₄₊ (Ref. 4) and La_{1:99}Sr_{0:01}CuO₄ (Ref. 5) single crystals, the magnetic eld applied parallel to the c axis induces a W F transition at the critical eld H_{W F} 4-5 T, which is accompanied by a large steplike negative magnetoresistance. W hatever the origin of this peculiar magnetoresistance is,^{5,13} the W F transition is the most clear evidence of a nite spin canting out of the CuO₂ plane that is inherent in the corrugated structure of CuO₂ planes characteristic of the LTO phase. The present results indicate that the lm grown on YAP actually has a corrugation in the CuO₂ plane similar to that in bulk crystals. The experimentally determined H_{W F} (= 4 T) in plies that the

In grown on YAP is almost identical to bulk crystals, because single crystals show almost the same transition eld^5 . However, it should be noted that the transition width across H_{W F} is broader in this Im than in reported crystals.^{4,5} This suggests a spatial inhom ogeneity of the transition eld due to a nite lattice m is t between the crystal and the substrate.

The magnetoresistance of the $\ln s$ grown on LSAT and STO is interesting. As shown in Fig. 1(e), the caxis lengths of these $\ln s$ are shorter than that of the bulk crystals. This implies that the tensile strain is actually applied to the $\ln s$, and thus we may expect the sym m etry of CuO₂ planes to become tetragonal following the substrate symmetry. On the other hand, as can be

seen in Figs. 4 (a) and 4 (b), a weakened but nite steplike m agnetoresistance rem ains, indicating that the corrugation in the CuO₂ plane survives. The most probable explanation is that these Im s are separted in two parts: lower fully-strained layer and upper relaxed layer, and the corrugation structure rem aing in the relaxed layer is resposible for the steplike magnetoresistance. If lattice relaxation proceeds, the crystal will approach its original form with nite corrugation in the CuO₂ plane. However, there is no sign of bulk orthorhom bicity in these Im s as is dem onstrated by Figs. 2 (d) and 2 (e). In order to explain these results self consistently, we expect the lm to have a m icroscopic tw in structure: the Im s are separated into dom ains that are still orthorhom bic but their orthorhom bicity is not as large as in the lm s grown on YAP. In this case, the corrugation in the CuO_2 plane is reasonably suppressed leading to the reduction in the W F moment. Certainly, the magnitude of the W F mom ent cannot be evaluated directly from the m agnetoresistance. However, if the reduction in the W F moment really takes place, a substantial suppression of the e ective interplane coupling can be deduced from the experim entally observed reduction of H $_{W}$, because the product of $H_{W,F}$ and the magnitude of the W F m om ent is roughly proportional to the e ective inter-plane coupling. Such suppression of the interplane coupling is consistent with the scenario that the sym m etry of CuO₂ planes becom es less orthorhom bic.

Our results also show an advantage of LSAO over other substrates. The weak ferrom agnetism is more strongly suppressed in the Im grown on LSAO than in lm s grown on LSAT or STO. This is probably because that the lattice m is tofLSCO to LSAO is sm aller than those to STO and LSAT.¹⁴ W e emphasize that not only the tensile strain but also the compressive strain is helpful in removing the corrugation from the CuO_2 plane. This cannot be simply understood because the presence of corrugation implies that the CuO_2 plane has already been com pressed by a rather sm $all La_2 O_2$ blocking layer. W ith respect to this point, our results strongly indicate that the substrate sym m etry is also essential for the rem oval of corrugation, and that the tetragonal substrate works well for these particular LSCO thin Ims.

Finally, let us brie y discuss the AF long-range order in these lms, because not only $H_{W F}$ but also T_N seems s to be a ected by the epitaxial strain. Figures 4 (c)-4 (f) show the magnetoresistance measured at T = 100 K. In the lm grown on YAP and STO, we can nd weak ferrom agnetism at this temperature, indicating that T_N of these lms is higher than 100 K. On the other hand, the magnetoresistance data for the lms grown on LASO and LSAT show no such features, suggesting that the system is still in the param agnetic phase, and the latter two lms probably have lower T_N 's than the form er ones or the bulk crystals. We consider that the reduction in T_N is also caused by the tetragonal symmetry that the substrate introduces to the lm. If CuO₂ planes are truly tetragonal and at, the inter-plane exchange interactions between the nearest-neighbor Cu ions on the adjacent layers are strongly frustrated. Consequently, a strong reduction in the elective interplane interactions is expected, which should suppress the form ation of the magnetic long-range order. Thus, the reduction in $T_{\rm N}$ together with H $_{\rm W\ F}$ also con $\,$ m s that the $\,$ lm s become less orthorhom bic.

To sum m arize, we have found that the in-plane m agnetoresistance of antiferrom agnetic LSCO thin lm s is strongly dependent on the substrate m aterial. The difference in the m agnetoresistance behavior is attributed

E lectronic address: ichiro@ criepidenken.or.p

- ¹ H.Sato and M.Naito, Physica C 274, 221 (1997); H.Sato, A.Tsukada, M.Naito, and A.Matsuda, Phys. Rev. B 61, 12447 (2000).
- ² H. Sato, A. Tsukada, M. Naito, and A. Matsuda, Phys. Rev.B 62, R799 (2000).
- ³ J.-P. Locquet, J. Perret, J. Fom peyrine, E. Machler, J. W. Seo, and G. Van Tendeloo, Nature (London) 394, 453 (1998).
- ⁴ T. Thio, T. R. Thurston, N. W. Preyer, P. J. Picone, M. A. Kastner, H. P. Jenssen, D. R. Gabbe, C. Y. Chen, R. J. Birgeneau, and A. Aharony, Phys. Rev. B 38, 905 (1988).
- ⁵ Y.Ando, A.N.Lavrov, and S.K om iya, Phys.Rev.Lett. 90, 247003 (2003).
- ⁶ A.N.Lavrov, I.T sukada, and Y.Ando, Phys. Rev. B 68, 094506 (2003).
- ⁷ A.N.Lavrov, Y.Ando, S.K om iya, and I.T sukada, Phys. Rev.Lett. 87, 017007 (2001).
- ⁸ I. Bozovic, G. Logvenov, I. Belca, B. Narim betov, and I. Sveklo, Phys. Rev Lett. 89, 107001 (2002).

to the change in the corrugation structure of the CuO₂ plane. W ithin our experiments, the attest CuO₂ plane is obtained in Im s grown on LaSrA IO₄ (001) substrates. It is suggested that not only the lattice parameters of the substrate but also its symmetry plays a signi cant role in rem oving the corrugations. We expect that a similar epitaxial strain works in superconducting LSCO thin Im s accounting for the observed T_c enhancement.

The author thanks A.N. Lavrov, Seiki Kom iya, and Yoichi Ando for stimulating discussions and also for a critical reading of the manuscript.

- ⁹ P.G.Radaelli, D.G.Hinks, A.W. Mitchell, B.A.Hunter, J.L.Wagner, B.Dabrowski, K.G.Vandervoort, H.K. Viswanathan, and J.D.Jorgensen, Phys.Rev.B 49, 4163 (1994).
- ¹⁰ T.Suzukiand T.Fujita, Physica C 159, 111 (1989).
- ¹¹ J.N.Eckstein, I.Bozovic, K.E.von Dessonneck, D.G. Schlom, J.S.Harris, Jr., and S.M.Baumann, Appl.Phys. Lett. 57, 931 (1990).
- ¹² Y.Ando, K.Segawa, S.Kom iya, and A.N.Lavrov, Phys. Rev.Lett. 88, 137005 (2002).
- ¹³ L. Shekhtman, I. Ya. Korenblit, and A. Aharony, Phys. Rev.B 49, 7080 (1994).
- ¹⁴ W e should calculate the m is t both along the a and b axis for LTO LSCO.By using the lattice parameters of bulk sam ples (Ref.[10]), the m is t is 0.85% (k a) and 1.60% (k b) to LSAO, -2.10% (k a) and -1.37% (k b) to LSAT, and -2.99% (k a) and -2.26% (k b) to STO.The sm allest m is t is achieved to LSAO both along a and along b.